

ABSTRACT

A testing circuit and a testing method are provided. The testing circuit includes: a first sampling module configured to receive a to-be-tested pulse signal, and generate a first sampled signal according to the pulse signal; and a second sampling module configured to receive the pulse signal, and generate a second sampled signal according to the pulse signal. The second sampled signal and the first sampled signal have a phase difference, the phase difference being equal to a pulse width of the pulse signal.